



Report No.:SZ11030089E03

47 CFR PART 15B

TEST REPORT

Issued to

Cellon Communications Technology (ShenZhen)Co., Ltd.

For

GSM Mobile Phone

Model Name: C2053, PCD1401, PCD1401PE, PCD1401AL, PCD1401CL, PCD1401PO, PCD1401MV, PCD1401OM, PCD1401MX, PCD1401CA, PCD1401AR, CL1401, CL1401CL, CL1401PO, CL1401CA, CL1401EN, TE1401, TE1401PE, TE1401MX, TE1401CA, AL1401AL, MV1401MV, TE1401SV, TE1401GT

Brand Name: PCD

FCC ID: T38PCD2053

Test Rule: 47 CFR Part 15 Subpart B

Test date: March 11, 2011 – March 18, 2011

Shenzhen Morlab Communications Technology Co., Ltd.

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2011.3.22

CTIA Authorized Test Lab
LAB CODE 20081223-00

IEEE 1725

OTA

OFTA

電訊管理局



GCF
Official Observer of
Global Certification Forum

Bluetooth
BQTF

FCC
Reg. No.
741109

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TABLE OF CONTENTS

1. GENERAL INFORMATION	3
1.1 EUT Description	3
1.2 Test Standards and Results	4
1.3 Facilities and Accreditations	5
1.3.1 Facilities	5
1.3.2 Test Environment Conditions	5
1.3.3 Measurement Uncertainty	5
2. TEST CONDITIONS SETTING	6
2.1 Test Mode	6
2.2 Test Setup and Equipments List	7
2.2.1 Conducted Emission	7
2.2.2 Radiated Emission	8
3. 47 CFR PART 15B REQUIREMENTS	9
3.1 Conducted Emission	9
3.1.1 Requirement	9
3.1.2 Test Description	9
3.1.3 Test Result	9
4.1.3.1 GSM Test Mode	9
4.1.3.2 USB Test Mode	11
3.2 Radiated Emission	12
3.2.1 Requirement	12
3.2.2 Test Description	12
3.2.3 Test Result	12

Change History		
Issue	Date	Reason for change
1.0	March 18, 2011	First edition

1. GENERAL INFORMATION

1.1 EUT Description

EUT Type GSM Mobile Phone
Serial No. (n.a, marked #1 by test site)
Hardware Version..... C2053_MB_P1
Software Version PCD1401_1.00_PCD_PCD_US
Applicant..... Cellon Communications Technology (ShenZhen)Co., Ltd.
13/F, Skyworth Building C Gaoxin S. Ave. 1st, High-Tech industrial Park
NanShan, ShenZhen
Manufacturer..... Cellon Communications Technology (ShenZhen)Co., Ltd.
13/F, Skyworth Building C Gaoxin S. Ave. 1st, High-Tech industrial Park
NanShan, ShenZhen
Modulation Type GMSK
Power Supply Battery
Model Name: BTR381
Brand name: PCD
Capacitance: 980mAh
Rated voltage: 3.7V
Manufacturer: Sunwoda Electronic Co., Ltd
Manufacturer Address: Building C, Tong Fu Kang Industrial Area, Shi Yan,
Bao An district, Shenzhen
Ancillary Equipment 1 ... AC Adapter (Charger for Battery)
Model Name: CNR380
Brand Name: PCD
Serial No.: (n.a. marked #1 by test site)
Rated Input: ~ 100-240V, 50- 60Hz, 300mA
Rated Output: = 5.0V, 650mA
Manufacturer: DEE VAN ENTERPRISE CO., LTD.
Manufacturer Address: 4020 CLIPPER COURT FREMONT,CA
94538,U.S.A.

Note 1: The EUT is a GSM Mobile Phone; it supports GSM 850MHz, 1900MHz and GPRS. GSM 850MHz and 1900MHz are tested in this report.

Note 2: The EUT is equipped with a T-Flash card slot; equipped with a special port which can be connected to the ancillary equipments supplied by the manufacturer e.g. the AC Adapter and the USB Adapter Cable.

Note 3: For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15 (10-1-09 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.

1.3 Facilities and Accreditations

1.3.1 Facilities

Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L3572.

All measurement facilities used to collect the measurement data are located at 3/F, Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055 P. R. China. The test site is constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22; the FCC registration number is 741109.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 -60
Atmospheric Pressure (kPa):	86-106

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB

2. TEST CONDITIONS SETTING

2.1 Test Mode

1. GSM Test Mode

- (1) The first test mode (GSM)

The EUT configuration of the emission tests is EUT + Battery + Charger

During the measurement of Traffic operating mode, a communication link was established between the EUT and a System Simulator (SS). The EUT operated at GSM 850MHz mid ARFCN (190) and maximum output power (level 5).

- (2) The second test mode (GPRS)

The EUT configuration of the emission tests is EUT + Battery + Charger.

In this test mode, a GPRS link was established between the EUT and a System Simulator (SS); data was transmitted between EUT and System Simulator (SS), and maintained during the measurement.

NOTE: All test modes are performed, only the worst cases are recorded in this report.

2. USB Test Mode

- (1) The first test mode (USB)

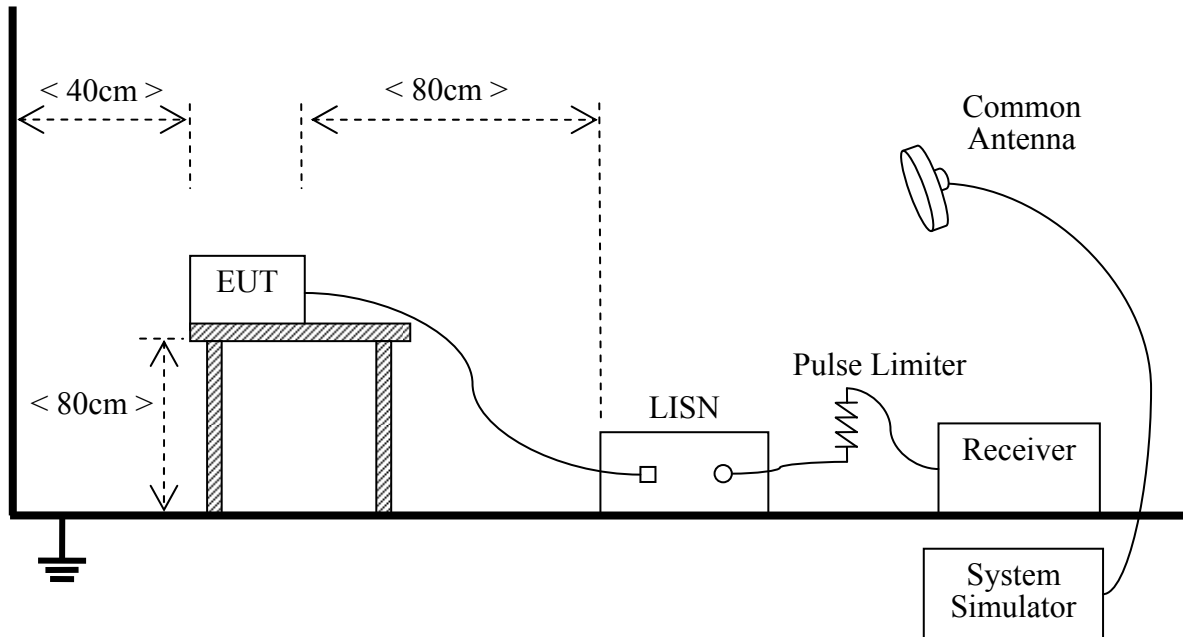
The EUT configuration of the emission tests is TransFlash Card + EUT + Battery + PC.

In this test mode, the EUT with a Trans Flash Card embedded is connected with a PC via a special USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), simultaneously, the data is transmitting between the PC and the TransFlash Card of the EUT.

2.2 Test Setup and Equipments List

2.2.1 Conducted Emission

A. Test Setup:



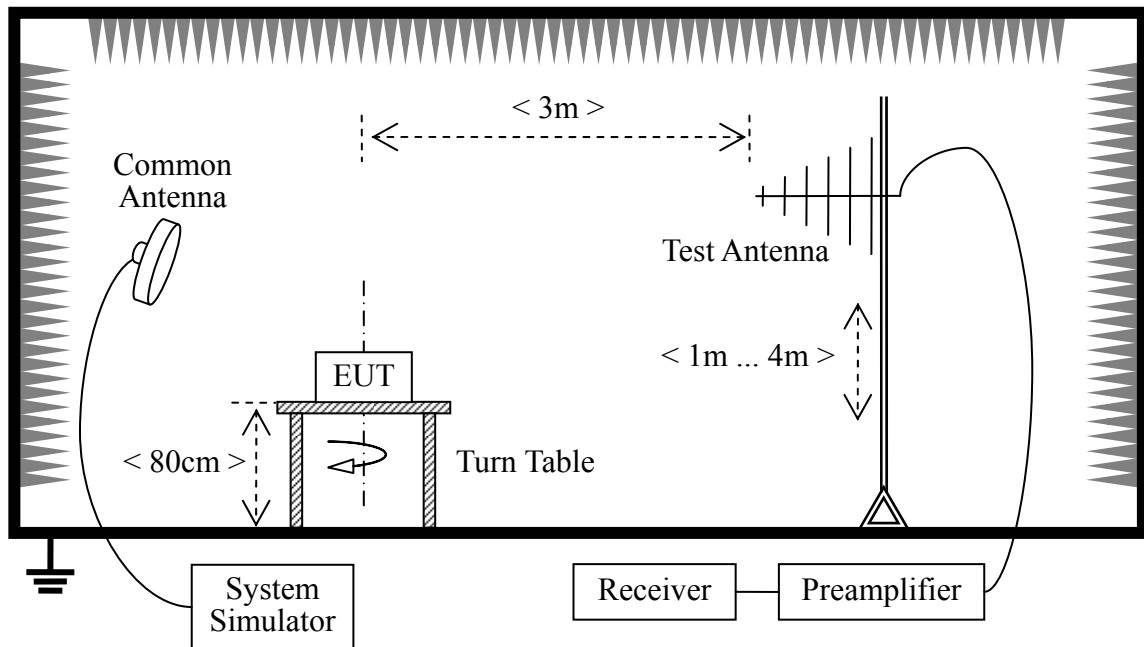
The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu\text{H}$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date
Receiver	Agilent	E7405A	US44210471	2010.09
LISN	Schwarzbeck	NSLK 8127	812744	2010.09
Pulse Limiter (20dB)	Schwarzbeck	VTSD 9561-D	9391	(n.a.)
System Simulator	Agilent	E5515C	GB43130131	2009.09
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)

2.2.2 Radiated Emission

C. Test Setup:



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower. The Common Antenna is used for the call between the EUT and the System Simulator (SS).

D. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date
Receiver	Agilent	E7405A	US44210471	2010.09
Semi-Anechoic Chamber	Albatross	9m*6m*6m	(n.a.)	2010.09
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2010.09
Test Antenna - Horn	Schwarzbeck	BBHA 9120C	9120C-384	2010.09
System Simulator	Agilent	E5515C	GB43130131	2010.09
Personal Computer	IBM	IBM_T20	(n.a.)	(n.a.)
Bluetooth-Headset	Nokia	HS-36W	(n.a.)	(n.a.)
T-Flash Card	SanDisk	256MB	(n.a.)	(n.a.)

3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

3.1.2 Test Description

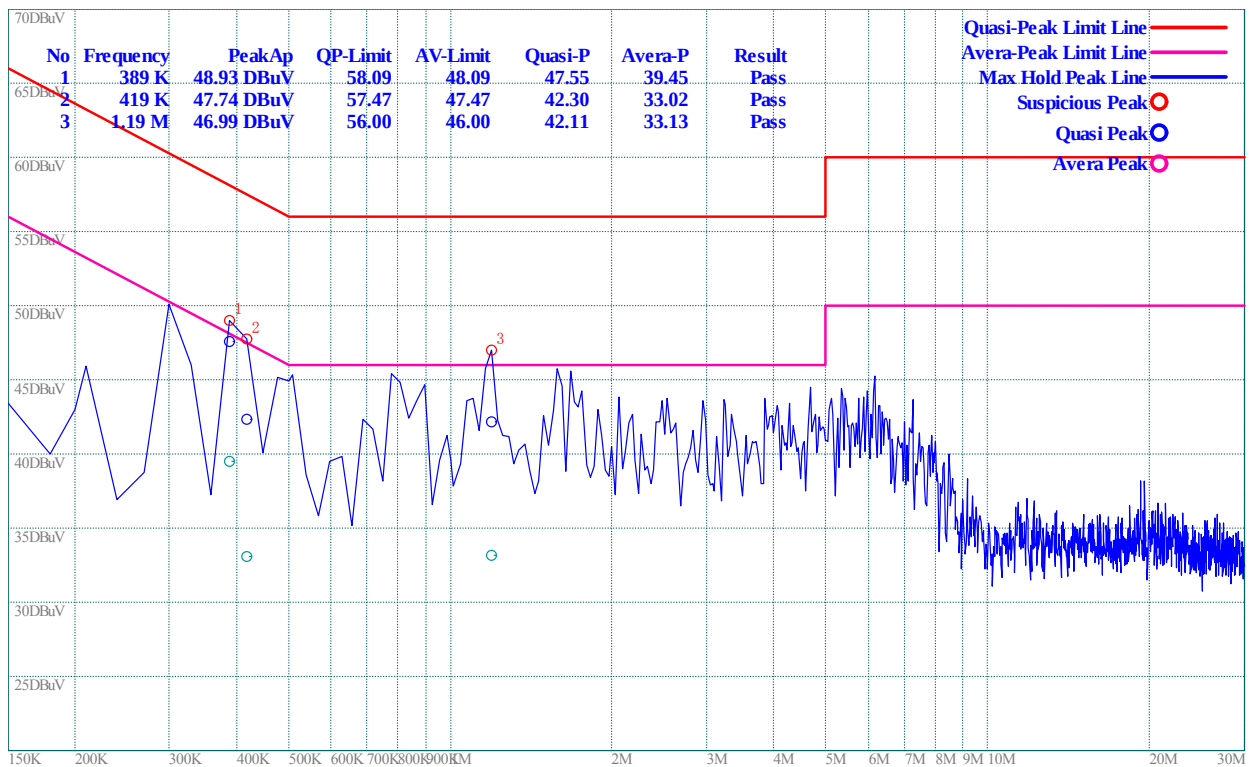
See section 2.2.1 of this report.

3.1.3 Test Result

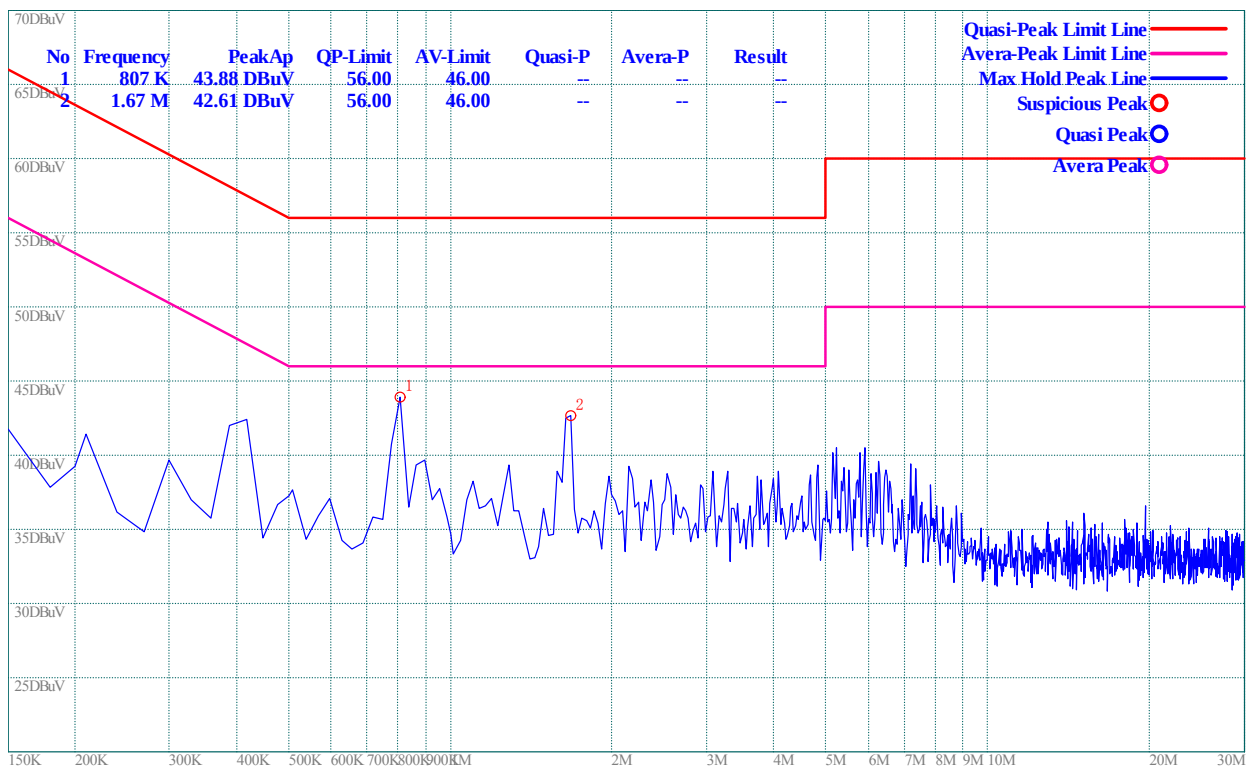
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

4.1.3.1 GSM Test Mode

A. Test Plot and Suspicious Points:



(Plot A: L Phase)

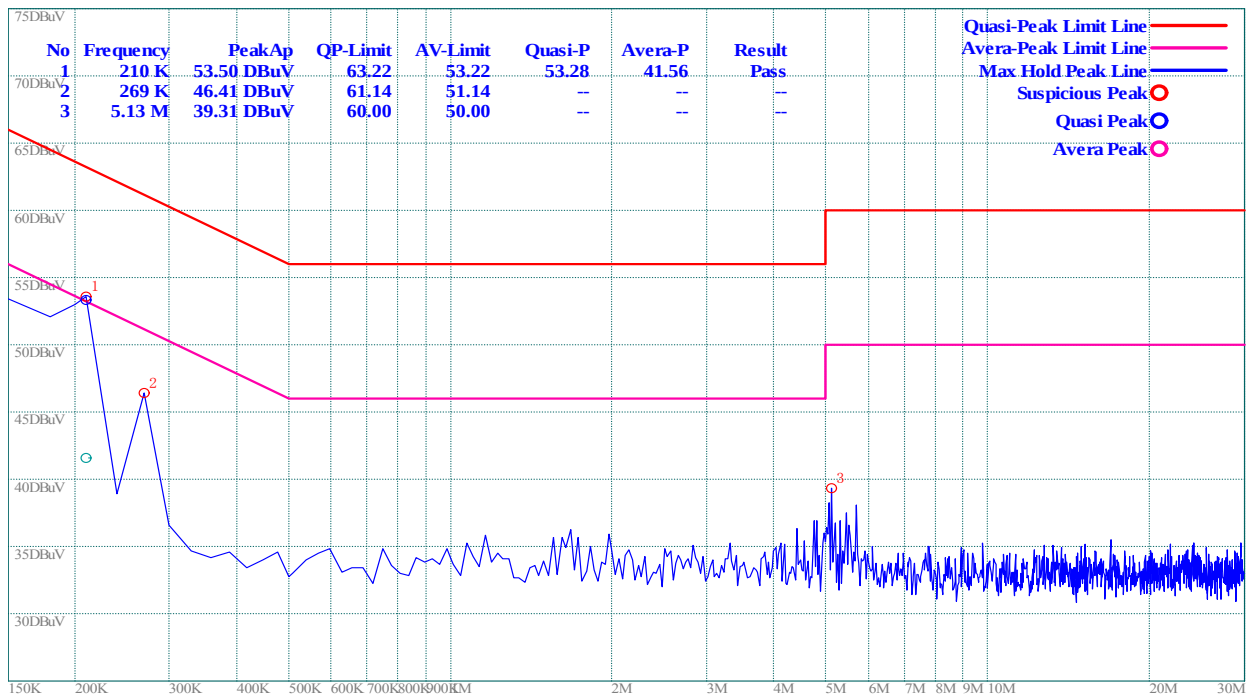


(Plot B: N Phase)

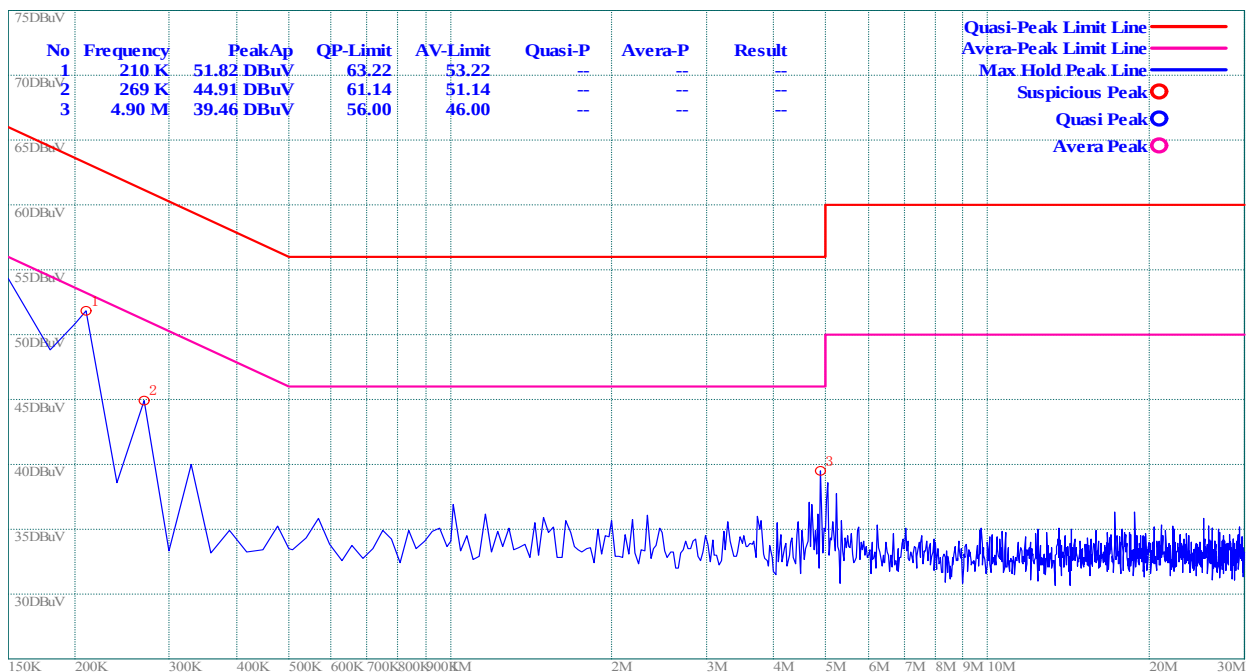
Test Result :PASS

4.1.3.2 USB Test Mode

A. Test Plot and Suspicious Points:



(Plot A: L Phase)



(Plot B: N Phase)

Test Result :PASS

3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength	
	$\mu\text{V/m}$	$\text{dB}\mu\text{V/m}$
30 - 88	100	40
88 - 216	150	43.5
216 - 960	200	46
Above 960	500	54

NOTE:

- a) Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
- b) In the emission tables above, the tighter limit applies at the band edges.

3.2.2 Test Description

See section 2.2.2 of this report.

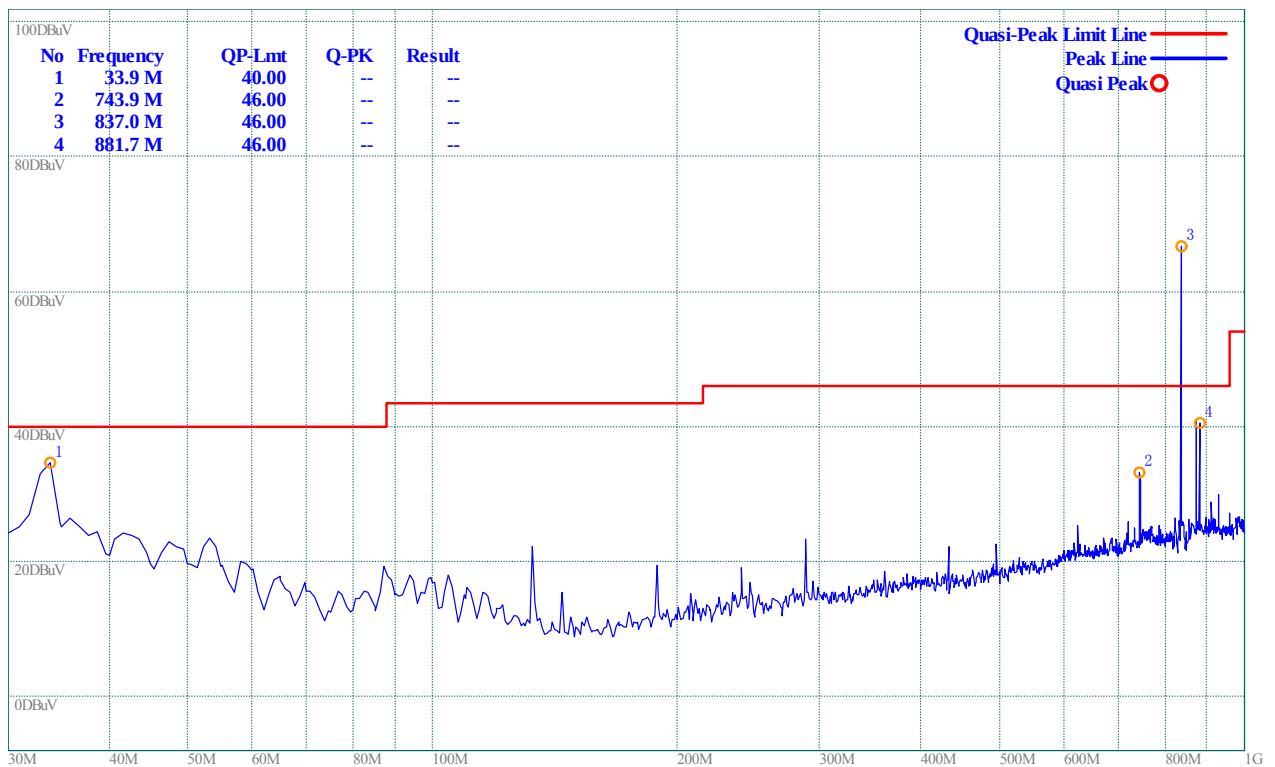
3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

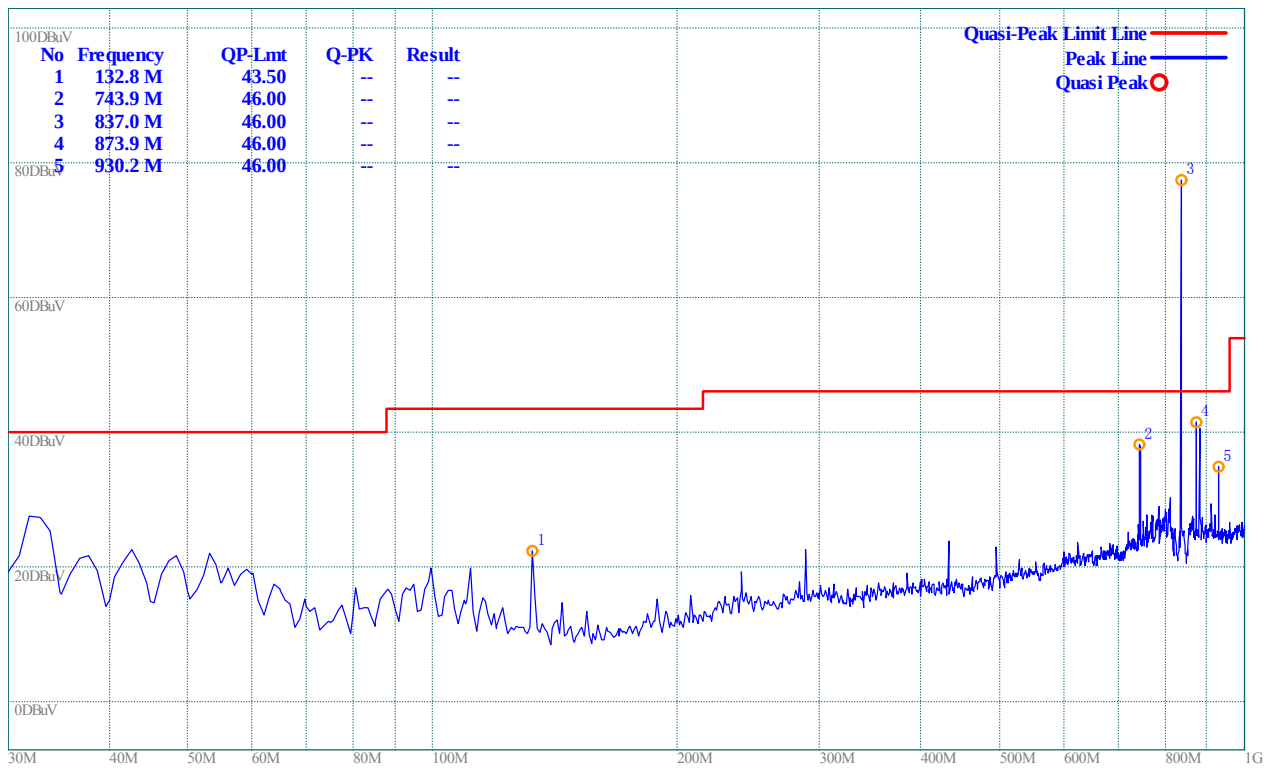
3.2.3.1 GSM Test Mode

A. Test Plot and Suspicious Points:

Note: Following is the plots for emission measurement; please note that marked spikes with circle should be ignored because they are MS and SS carrier frequency.



(Plot A: Test Antenna Vertical)

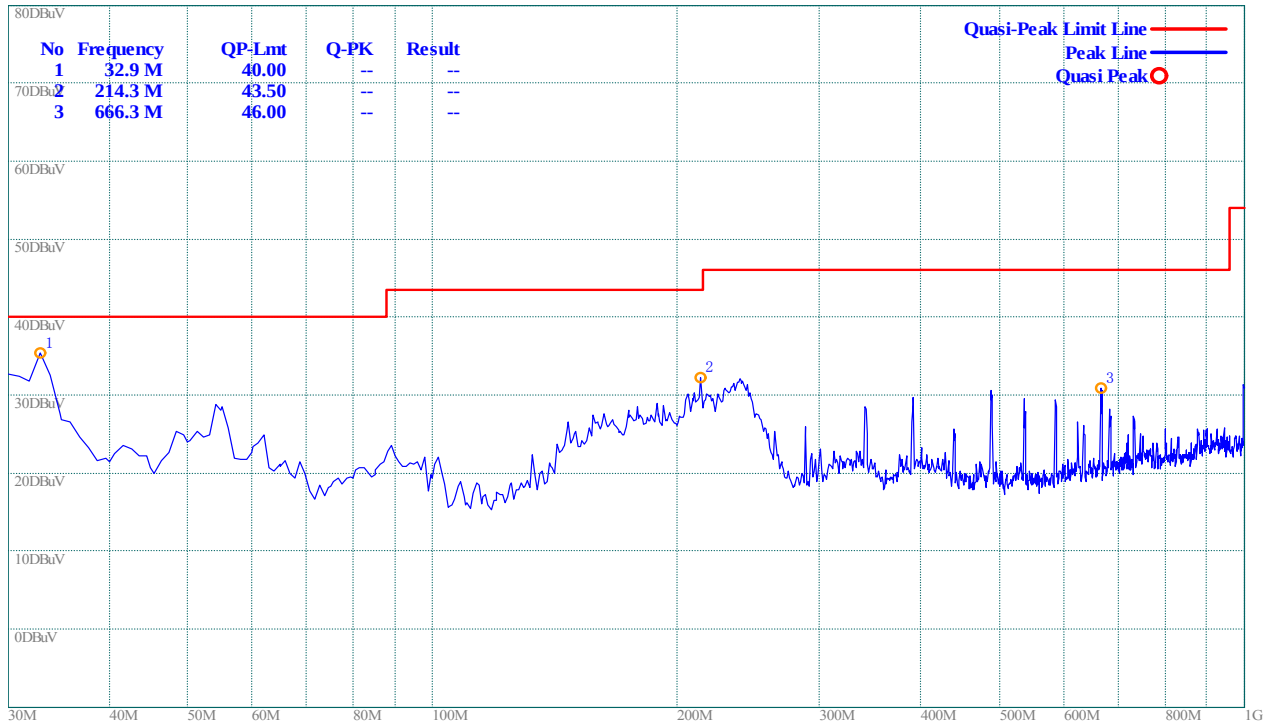


(Plot B: Test Antenna Horizontal)

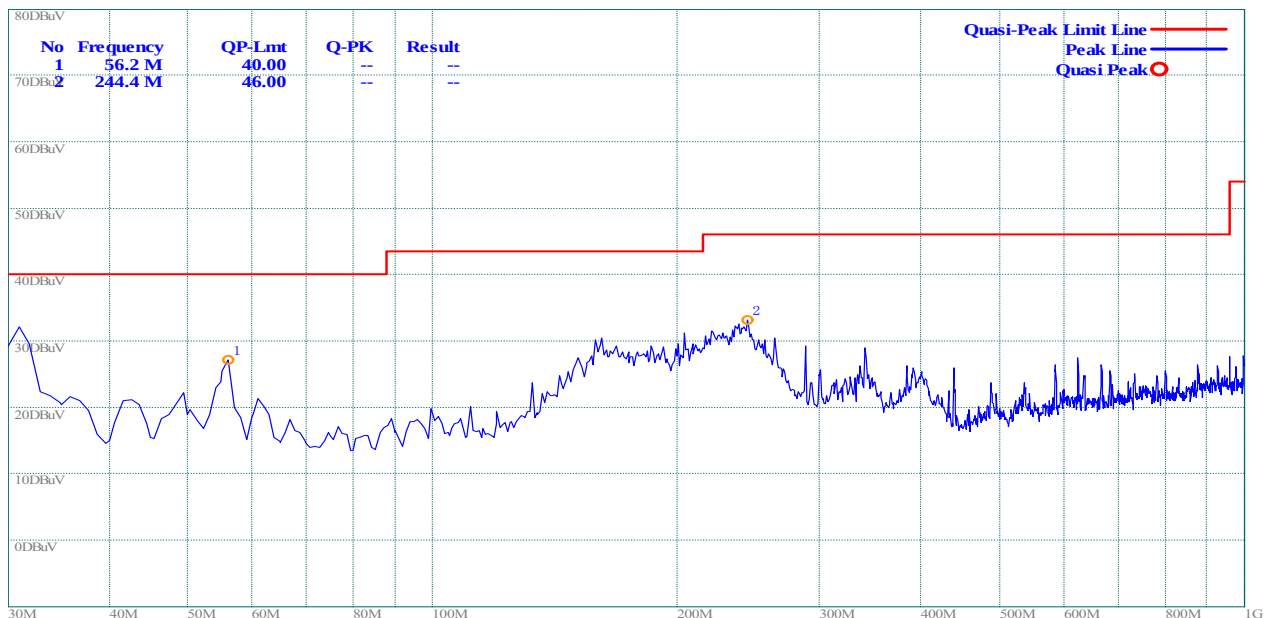
Test Result :PASS

3.2.3.2 USB Test Mode

A. Test Plot and Suspicious Points:



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

Test Result :PASS

**** END OF REPORT ****